

# PXP020-20QXJ-VB Datasheet

## P-Channel 20-V (D-S) MOSFET

PRODUCT SUMMARY			
V <sub>DS</sub> (V)	R <sub>DS(on)</sub> (Ω)	I <sub>D</sub> (A) <sup>d</sup>	Q <sub>g</sub> (Typ.)
- 20	0.016 at V <sub>GS</sub> = - 4.5 V	- 15	16 nC
	0.020 at V <sub>GS</sub> = - 2.5 V	- 10	

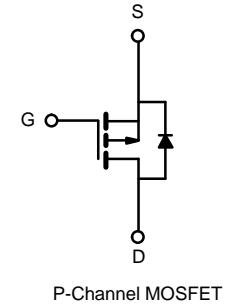
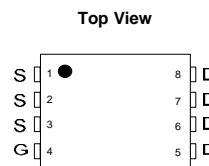
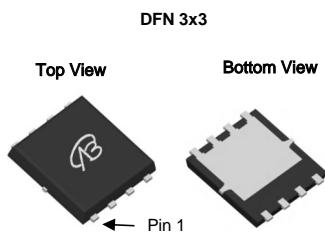
### FEATURES

- Halogen-free According to IEC 61249-2-21 Definition
- Trench Power MOSFET
- 100 % R<sub>g</sub> Tested



### APPLICATIONS

- Load Switch
- Battery Switch



### ABSOLUTE MAXIMUM RATINGS T<sub>A</sub> = 25 °C, unless otherwise noted

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V <sub>DS</sub>	- 20	V
Gate-Source Voltage	V <sub>GS</sub>	± 8	
Continuous Drain Current (T <sub>J</sub> = 150 °C)	I <sub>D</sub>	- 15	A
		- 12	
		- 10 <sup>a, b</sup>	
		- 8 <sup>a, b</sup>	
Pulsed Drain Current	I <sub>DM</sub>	- 150	
Continuous Source-Drain Diode Current	I <sub>S</sub>	- 45	W
		- 2.1 <sup>a, b</sup>	
Maximum Power Dissipation	P <sub>D</sub>	40	W
		27	
		2.5 <sup>a, b</sup>	
		1.6 <sup>a, b</sup>	
Operating Junction and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C

### THERMAL RESISTANCE RATINGS

Parameter	Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient <sup>a, c</sup>	R <sub>thJA</sub>	40	50	°C/W
Maximum Junction-to-Foot	R <sub>thJF</sub>	24	30	

Notes:

- Surface mounted on 1" x 1" FR4 board.
- t = 10 s.
- Maximum under Steady State conditions is 95 °C/W.
- Based on T<sub>C</sub> = 25 °C.

**SPECIFICATIONS**  $T_J = 25^\circ\text{C}$ , unless otherwise noted

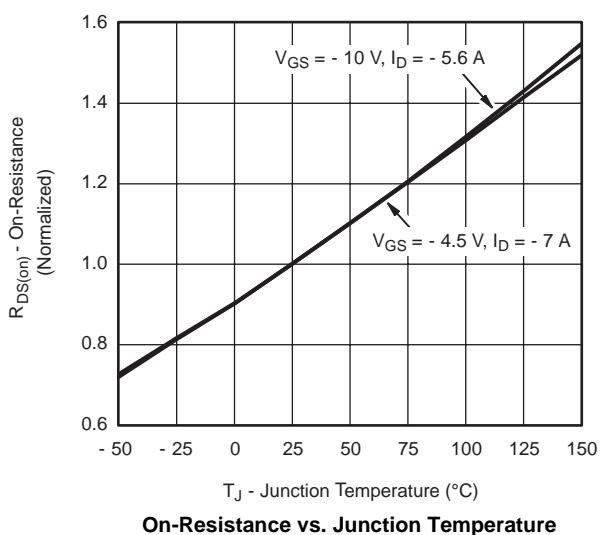
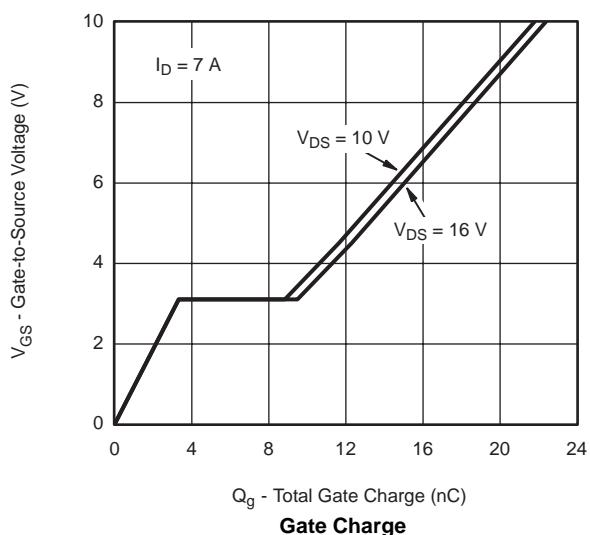
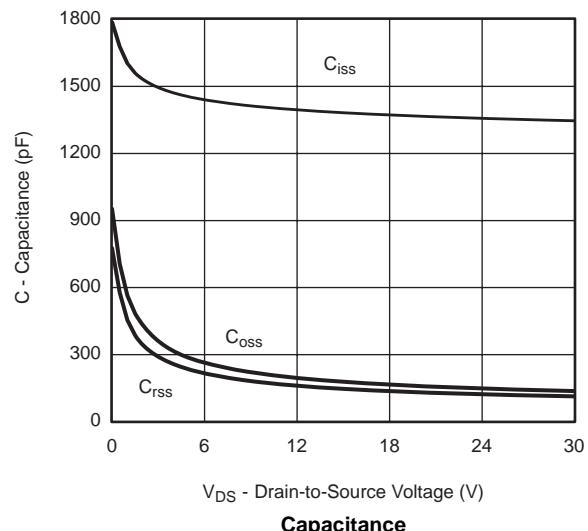
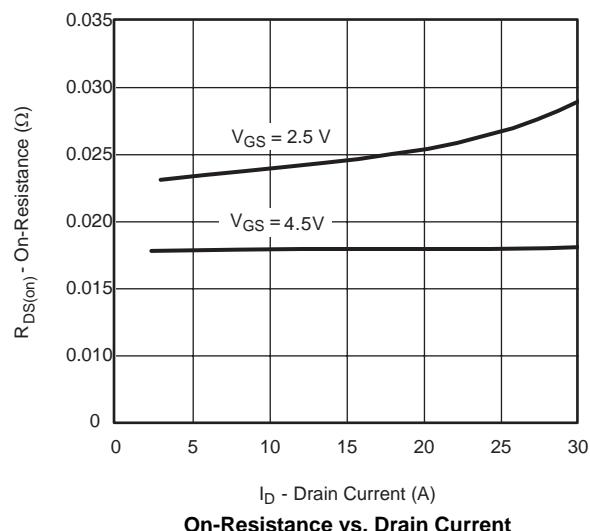
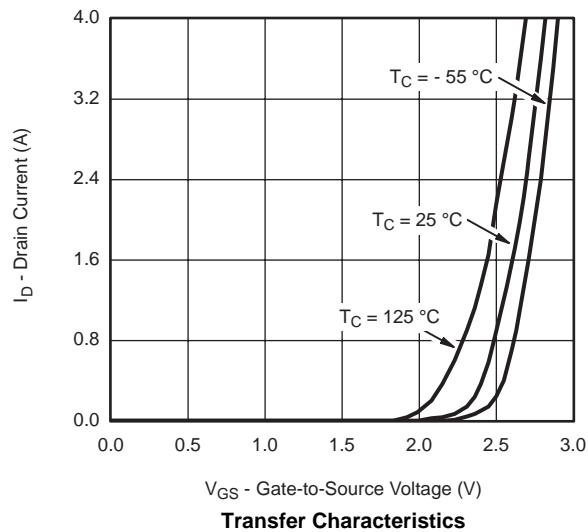
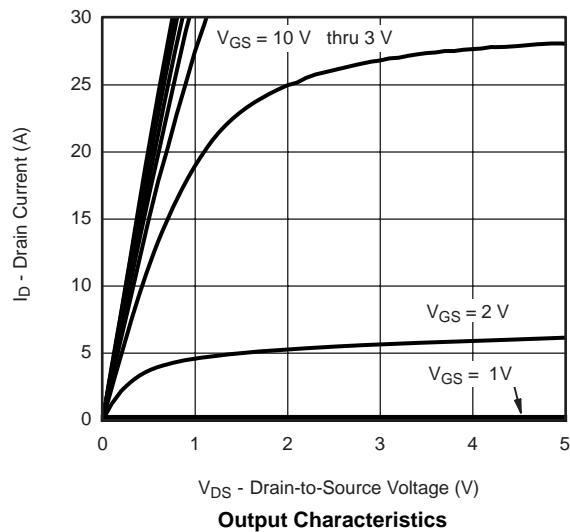
Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
<b>Static</b>						
Drain-Source Breakdown Voltage	$V_{DS}$	$V_{GS} = 0\text{ V}$ , $I_D = -250\text{ }\mu\text{A}$	- 20			V
$V_{DS}$ Temperature Coefficient	$\Delta V_{DS}/T_J$	$I_D = -250\text{ }\mu\text{A}$		- 31		
$V_{GS(\text{th})}$ Temperature Coefficient	$\Delta V_{GS(\text{th})}/T_J$			4.5		mV/°C
Gate-Source Threshold Voltage	$V_{GS(\text{th})}$	$V_{DS} = V_{GS}$ , $I_D = -250\text{ }\mu\text{A}$		- 0.6		V
Gate-Source Leakage	$I_{GSS}$	$V_{DS} = 0\text{ V}$ , $V_{GS} = \pm 8\text{ V}$			$\pm 100$	nA
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = -20\text{ V}$ , $V_{GS} = 0\text{ V}$			- 1	
		$V_{DS} = -20\text{ V}$ , $V_{GS} = 0\text{ V}$ , $T_J = 55^\circ\text{C}$			- 5	μA
On-State Drain Current <sup>a</sup>	$I_{D(\text{on})}$	$V_{DS} \leq -5\text{ V}$ , $V_{GS} = -10\text{ V}$	- 40			A
Drain-Source On-State Resistance <sup>a</sup>	$R_{DS(\text{on})}$	$V_{GS} = -4.5\text{ V}$ , $I_D = -7.0\text{ A}$		0.016		
		$V_{GS} = -2.5\text{ V}$ , $I_D = -5.6\text{ A}$		0.020		Ω
Forward Transconductance <sup>a</sup>	$g_{fs}$	$V_{DS} = -15\text{ V}$ , $I_D = -7.0\text{ A}$		18		S
<b>Dynamic<sup>b</sup></b>						
Input Capacitance	$C_{iss}$	$V_{DS} = -10\text{ V}$ , $V_{GS} = 0\text{ V}$ , $f = 1\text{ MHz}$		1500		
Output Capacitance	$C_{oss}$			180		
Reverse Transfer Capacitance	$C_{rss}$			145		pF
Total Gate Charge	$Q_g$	$V_{DS} = -10\text{ V}$ , $V_{GS} = -10\text{ V}$ , $I_D = -7.0\text{ A}$		25	38	
Gate-Source Charge	$Q_{gs}$			13	20	
Gate-Drain Charge	$Q_{gd}$			3.5		
Gate Resistance	$R_g$		$f = 1\text{ MHz}$	0.4	2.0	4.0
Turn-On Delay Time	$t_{d(\text{on})}$	$V_{DD} = -10\text{ V}$ , $R_L = 2.7\text{ }\Omega$ $I_D \geq -5.6\text{ A}$ , $V_{GEN} = -10\text{ V}$ , $R_g = 1\text{ }\Omega$		10	20	
Rise Time	$t_r$			13	20	
Turn-Off DelayTime	$t_{d(\text{off})}$			23	35	
Fall Time	$t_f$			9	18	
Turn-On Delay Time	$t_{d(\text{on})}$	$V_{DD} = -10\text{ V}$ , $R_L = 2.7\text{ }\Omega$ $I_D \geq -5.6\text{ A}$ , $V_{GEN} = -4.5\text{ V}$ , $R_g = 1\text{ }\Omega$		38	57	
Rise Time	$t_r$			89	134	
Turn-Off DelayTime	$t_{d(\text{off})}$			22	33	
Fall Time	$t_f$			11	17	ns
<b>Drain-Source Body Diode Characteristics</b>						
Continous Source-Drain Diode Current	$I_S$	$T_C = 25^\circ\text{C}$			- 15	
Pulse Diode Forward Current	$I_{SM}$				- 45	A
Body Diode Voltage	$V_{SD}$	$I_S = -5.6\text{ A}$ , $V_{GS} = 0\text{ V}$		- 0.71	- 1.2	V
Body Diode Reverse Recovery Time	$t_{rr}$	$I_F = -5.6\text{ A}$ , $dI/dt = 100\text{ A}/\mu\text{s}$ , $T_J = 25^\circ\text{C}$		22	33	ns
Body Diode Reverse Recovery Charge	$Q_{rr}$			17	26	nC
Reverse Recovery Fall Time	$t_a$			13		
Reverse Recovery Rise Time	$t_b$			9		ns

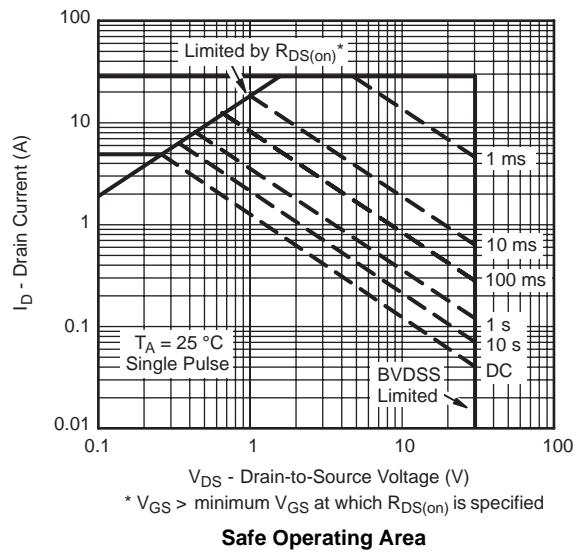
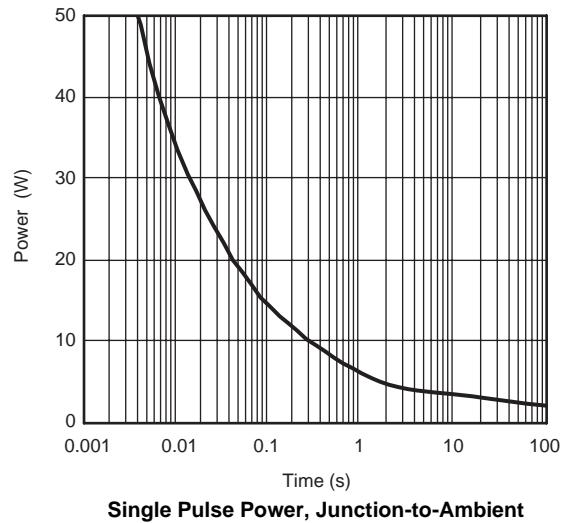
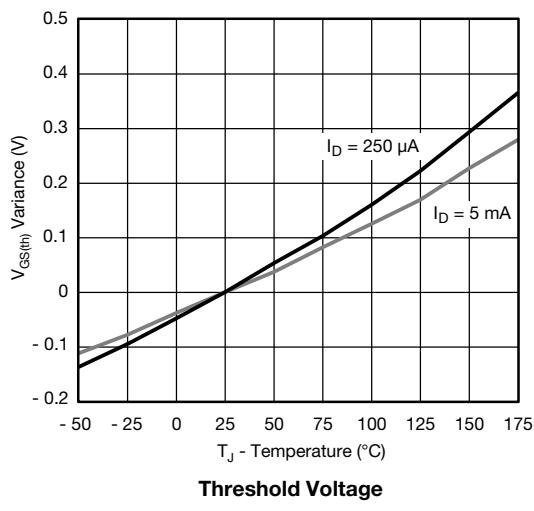
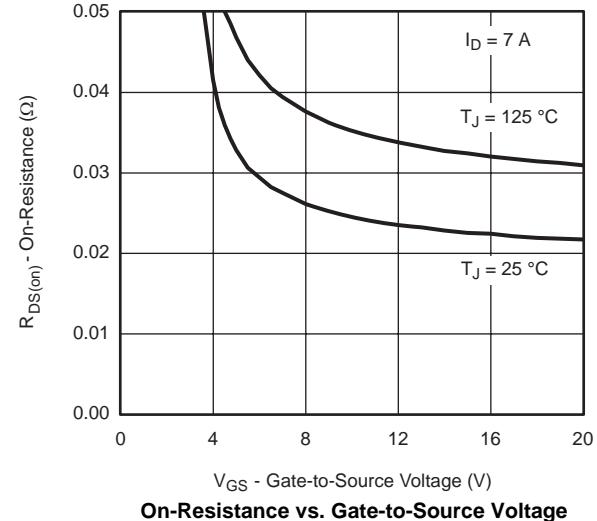
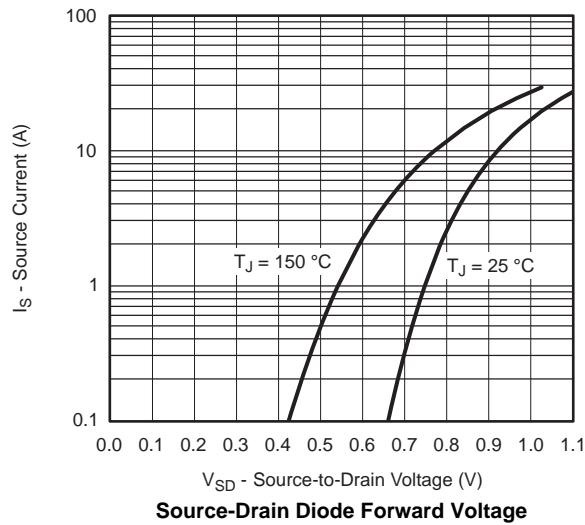
Notes:

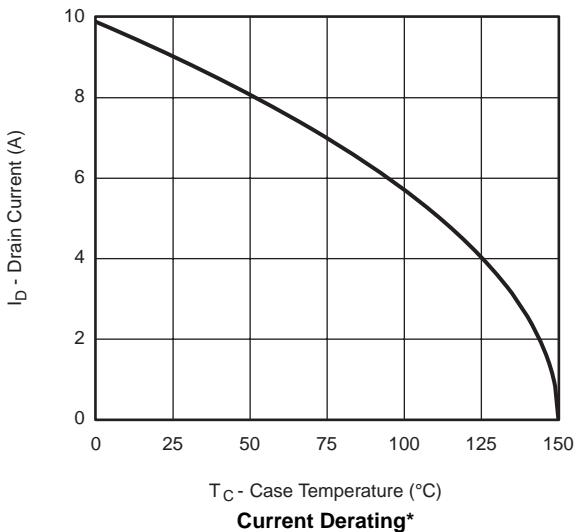
a. Pulse test; pulse width  $\leq 300\text{ }\mu\text{s}$ , duty cycle  $\leq 2\%$ .

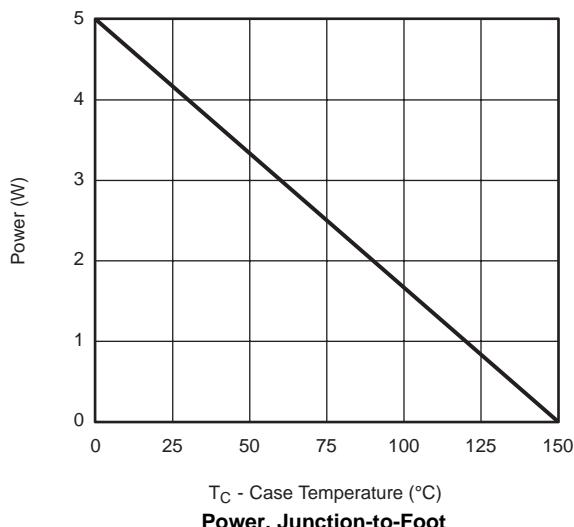
b. Guaranteed by design, not subject to production testing.

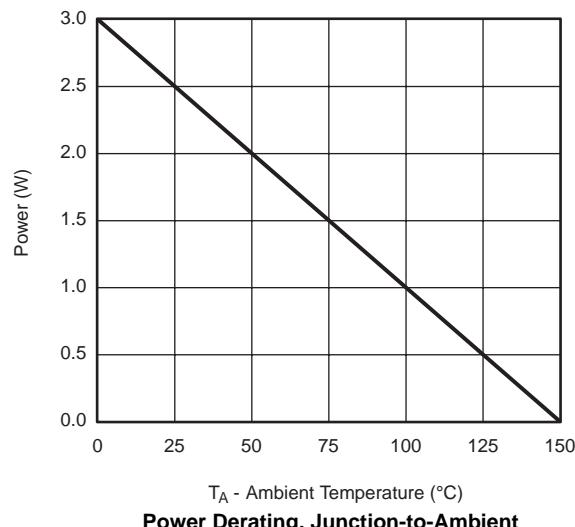
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

**TYPICAL CHARACTERISTICS** 25 °C, unless otherwise noted


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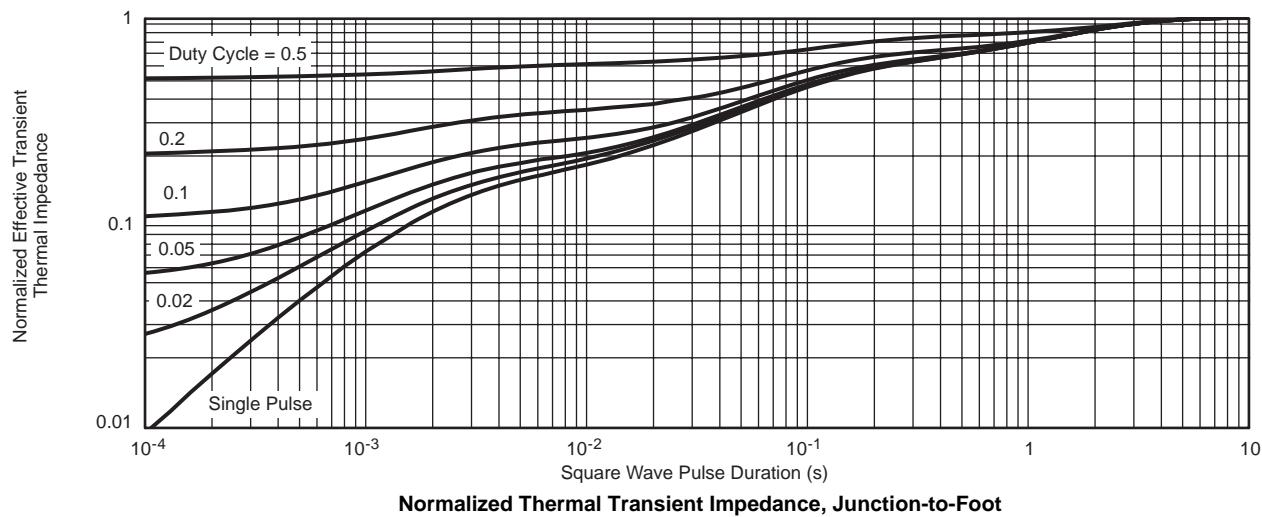
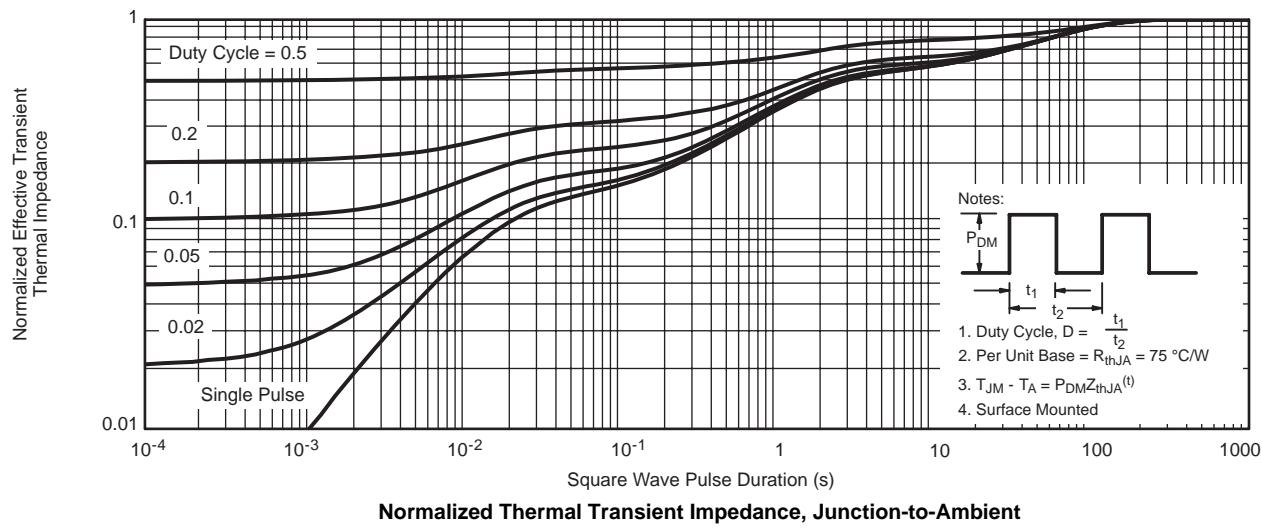
**TYPICAL CHARACTERISTICS** 25 °C, unless otherwise noted

 $T_C$  - Case Temperature (°C)

**Current Derating\***

 $T_C$  - Case Temperature (°C)

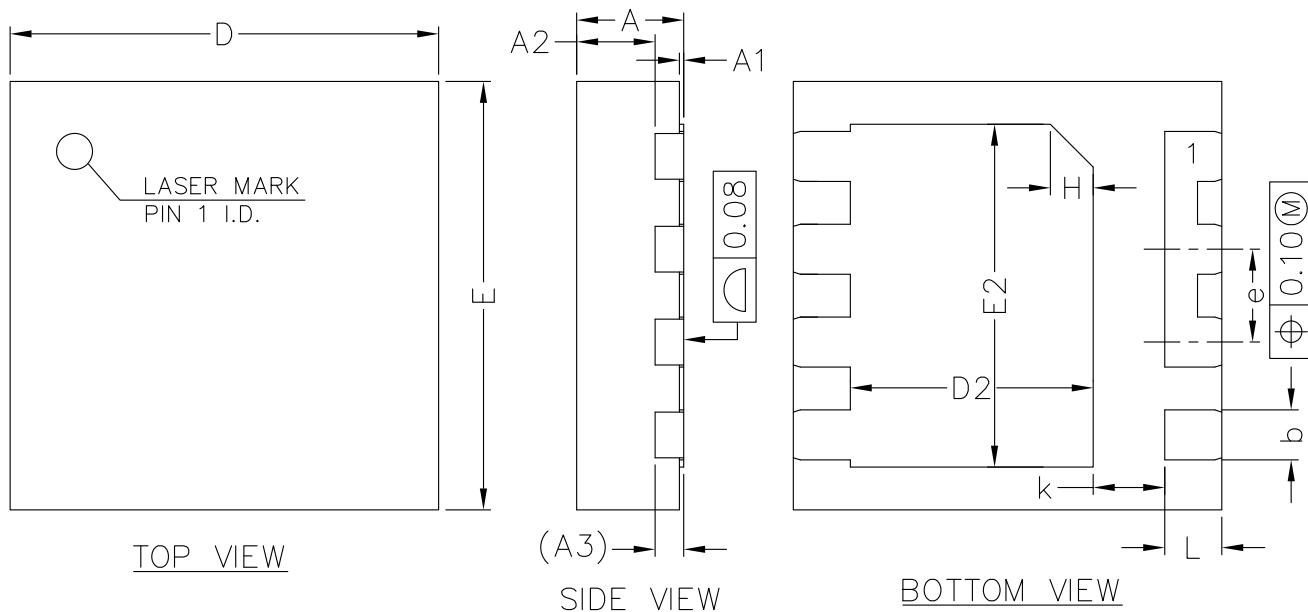
**Power, Junction-to-Foot**

 $T_A$  - Ambient Temperature (°C)

**Power Derating, Junction-to-Ambient**

\* The power dissipation  $P_D$  is based on  $T_{J(max)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

**TYPICAL CHARACTERISTICS** 25 °C, unless otherwise noted


DFN3x3



SIDE VIEW

COMMON DIMENSIONS  
 (UNITS OF MEASURE=MILLIMETER)

SYMBOL	MIN	NOM	MAX
A	0.70	0.75	0.80
A1	0.00	0.02	0.05
A2	0.50	0.55	0.60
A3	0.20REF		
b	0.30	0.35	0.40
D	2.90	3.00	3.10
E	2.90	3.00	3.10
D2	1.60	1.70	1.80
E2	2.30	2.40	2.50
e	0.55	0.65	0.75
K	0.40	0.50	0.60
L	0.35	0.40	0.45

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